

**Search Notes**

Application/Control No.

10/694,760

Examiner

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Applicant(s)/Patent under  
Reexamination

UEMURA, TOSHIYA

Art Unit

2818

**SEARCHED**

Class	Subclass	Date	Examiner
257	103	2/28/2005	TTN
257	13	2/28/2005	TTN
257	14	2/28/2005	TTN
257	96	2/28/2005	TTN
257	622	3/1/2005	TTN
257	614	3/1/2005	TTN
257	627	3/1/2005	TTN
257	631	3/1/2005	TTN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
257	103	3/1/2005	TTN
257	622	3/1/2005	TTN

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	2/28/2005	TTN
EAST	3/1/2005	TTN